

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	2076	((determin\$4 detect\$4 inspect\$4 measur\$4) with thickness with temperature)	US-PGPUB	OR	ON	2005/08/29 13:06
L2	211	((determin\$4 detect\$4 inspect\$4 measur\$4) with thickness with temperature).clm.	US-PGPUB	OR	ON	2005/08/29 13:14
L3	12	((determin\$4 detect\$4 inspect\$4 measur\$4) with thickness with temperature with (voltage current)).clm.	US-PGPUB	OR	ON	2005/08/29 13:16
L4	16	((determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4) with thickness with temperature with (voltage current)).clm.	US-PGPUB	OR	ON	2005/08/29 14:09
L5	229	((determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4) with thickness with temperature).clm.	US-PGPUB	OR	ON	2005/08/29 13:18
L6	0	((determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4) with thickness with temperature with (pcb (circuit adj board))).clm.	US-PGPUB	OR	ON	2005/08/29 13:19
L7	34589	((determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4) with (current voltage)).clm.	US-PGPUB	OR	ON	2005/08/29 13:59
L8	35	5 and 7	US-PGPUB	OR	ON	2005/08/29 13:37
L9	4	("6861834") or ("6714026")).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/08/29 13:37
L13	3011	((324/126,142,699,105,102) or (702/57-60) or (338/49)).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/08/29 15:20
L14	134	7 and 13	US-PGPUB	OR	ON	2005/08/29 13:59
L15	51	14 and temperature	US-PGPUB	OR	ON	2005/08/29 14:13
L16	3486	(determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4 obtain\$4) with thickness with temperature	US-PGPUB	OR	ON	2005/08/29 14:12
L17	3	13 and 16	US-PGPUB	OR	ON	2005/08/29 14:13
L18	67667	(determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4 obtain\$4) with thickness	US-PGPUB	OR	ON	2005/08/29 15:09
L19	13	13 and 18	US-PGPUB	OR	ON	2005/08/29 14:13
L20	8	19 and temperature	US-PGPUB	OR	ON	2005/08/29 14:15
L21	121	(324/699).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/08/29 14:15

L22	463	(324/126).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/08/29 14:57
L23	463	(324/126).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/08/29 14:57
L24	423340	(determin\$4 detect\$4 inspect\$4 measur\$4 calculat\$4 obtain\$4) with thickness	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:09
L25	214417	24 and temperature	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:10
L26	26941	25 and ((measur\$4 determin\$4 obtain\$4)with voltage)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:11
L27	29	13 and 26	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:17
L28	1464514	(measur\$4 detect\$4 determin\$4 obtain\$4 calculat\$4)with (power resistance thickness)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:18
L29	72038	28 and (measur\$4 with (voltage current))and temperature	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:19
L30	6427	29 and ((strip thread wire)with temperature)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:20
L31	48	30 and 13	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:21

L32	5044	((324/126,142,699,105,102) or (702/57-60) or (338/49)).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/08/29 15:20
L33	77	30 and 32	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/08/29 15:21